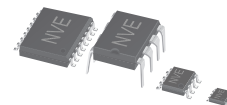
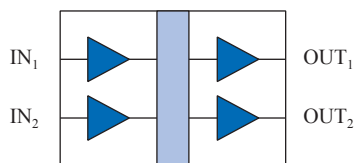


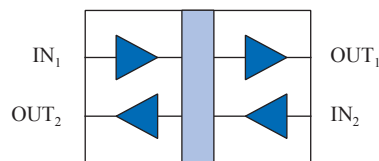
High Speed Two-Channel Digital Isolators



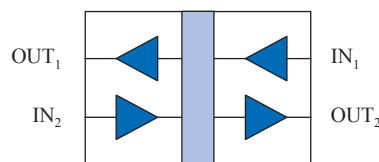
Functional Diagrams



IL711



IL712



IL721

Features

- High speed: 150 Mbps typical (S-Series)
- High temperature: -40°C to $+125^{\circ}\text{C}$ (T-Series and VE-Series)
- Very high isolation: 6 kV_{RMS} Reinforced Isolation (VE-Series)
- High working voltage: 1 kV_{RMS} per VDE V 0884-10 (VE-Series)
- 50 kV/ μs typ.; 30 kV/ μs min. common mode transient immunity
- No carrier or clock for low EMI emissions and susceptibility
- 1.2 mA/channel typical quiescent current
- 300 ps typical pulse width distortion (S-Series)
- 100 ps pulse jitter
- 2 ns channel-to-channel skew
- 10 ns typical propagation delay
- 44000 year barrier life
- Excellent magnetic immunity
- VDE V 0884-10 certified; UL 1577 recognized
- MSOP, SOIC, PDIP, and True 8 mm creepage packages

Applications

- Board-to-board communication
- CANbus
- Peripheral interfaces
- Logic level shifting
- Equipment covered under IEC 61010-1 Edition 3
- 5 kV_{RMS} rated IEC 60601-1 medical applications

Description

NVE's IL700 family of high-speed digital isolators are CMOS devices manufactured with NVE's patented* IsoLoop[®] spintronic Giant Magnetoresistive (GMR) technology. A unique ceramic/polymer composite barrier provides excellent isolation and virtually unlimited barrier life.

The IL711S and IL712S are the world's fastest two-channel isolators, with a 150 Mbps typical data rate for both channels. Standard and S-Grade parts are specified over a temperature range of -40°C to $+100^{\circ}\text{C}$; "T" and "VE" Grade parts have a maximum operating temperature of 125°C . V-Series versions offer extremely high isolation voltages of 6 kV_{RMS} for wide-body packages and 2.5 kV_{RMS} for MSOPs.

The symmetric magnetic coupling barrier provides a typical propagation delay of only 10 ns and a pulse width distortion as low as 300 ps (0.3 ns), achieving the best specifications of any isolator. Typical transient immunity of 50 kV/ μs is unsurpassed.

The IL711 has two transmit channels; the IL712 and IL721 have one transmit and one receive channel. The IL721 has channels reversed to better suit certain board layouts.

The IL711 and IL712 are available in 8-pin MSOP, SOIC, and PDIP packages. The IL711 and IL721 are also available in NVE's unique JEDEC-compliant 16 pin package with True 8 mm creepage under IEC 60601.

Absolute Maximum Ratings

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Storage Temperature	T_S	-55		150	°C	
Junction Temperature	T_J	-55		150	°C	
Ambient Operating Temperature ⁽¹⁾ IL711T/IL711VE/IL712T/IL721T/IL721VE	T_A	-40		100 125	°C	
Supply Voltage	V_{DD1}, V_{DD2}	-0.5		7	V	
Input Voltage	V_I	-0.5		$V_{DD} + 0.5$	V	
Output Voltage	V_O	-0.5		$V_{DD} + 0.5$	V	
Output Current Drive	I_O			10	mA	
Lead Solder Temperature				260	°C	10 sec.
ESD			2		kV	HBM

Recommended Operating Conditions

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Ambient Operating Temperature IL711T/IL711VE/IL712T/IL721T/IL721VE	T_A	-40 -40		100 125	°C	
Junction Temperature IL711T/IL711VE/IL712T/IL721T/IL721VE	T_J	-40 -40		110 125	°C	
Supply Voltage	V_{DD1}, V_{DD2}	3.0		5.5	V	
Logic High Input Voltage	V_{IH}	2.4		V_{DD}	V	
Logic Low Input Voltage	V_{IL}	0		0.8	V	
Input Signal Rise and Fall Times	t_{IR}, t_{IF}			1	μs	

Insulation Specifications

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Creepage Distance (external)						
MSOP8		3.01			mm	
SOIC8		4.03			mm	
PDIP8		7.04			mm	
True 8™ 0.3" SOIC16		8.03	8.3		mm	Per IEC 60601
Total Barrier Thickness (internal)		0.012	0.016		mm	
Leakage Current ⁽⁵⁾			0.2		μA	240 V_{RMS} , 60 Hz
Barrier Resistance ⁽⁵⁾	R_{IO}		$>10^{14}$		Ω	500 V
Barrier Capacitance ⁽⁵⁾	C_{IO}		2		pF	f = 1 MHz
Comparative Tracking Index	CTI	≥600			V_{RMS}	Per IEC 60112
High Voltage Endurance (Maximum Barrier Voltage for Indefinite Life)	AC V_{IO} DC	1000 1500			V_{RMS} V_{DC}	At maximum operating temperature
Surge Immunity ("VE" Versions)	V_{IOSM}	12.8			kV _{PK}	Per IEC 61000-4-5
Barrier Life			44000		Years	100°C, 1000 V_{RMS} , 60% CL activation energy

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Junction–Ambient Thermal Resistance	θ_{JA}		80 60 60 60		°C/W	Soldered to double-sided board; free air
Junction–Case (Top) Thermal Resistance	Ψ_{JT}		40 10 20 20		°C/W	
Power Dissipation	P_D			500 675 800 800	mW	

Safety and Approvals

VDE V 0884-10 (VDE V 0884-11 pending)

VE versions (0.3" SOIC Reinforced Isolation; VDE File Number 5016933-4880-0002)

- Working Voltage (V_{IORM}) 1000 V_{RMS} (1415 V_{PK}); reinforced insulation; pollution degree 2
- Isolation voltage (V_{ISO}) 6000 V_{RMS}
- Surge immunity (V_{IOSM}) 12.8 kV $_{PK}$
- Surge rating 8 kV
- Transient overvoltage (V_{IOTM}) 6000 V_{PK}
- Each part tested at 2387 V_{PK} for 1 second, 5 pC partial discharge limit
- Samples tested at 6000 V_{PK} for 60 sec.; then 2122 V_{PK} for 10 sec. with 5 pC partial discharge limit

Standard versions (Basic Isolation; VDE File Number 5016933-4880-0001)

- Working Voltage (V_{IORM}) 600 V_{RMS} (848 V_{PK}); basic insulation; pollution degree 2
- Isolation voltage (V_{ISO}) 2500 V_{RMS}
- Transient overvoltage (V_{IOTM}) 4000 V_{PK}
- Surge rating 4000 V
- Each part tested at 1590 V_{PK} for 1 second, 5 pC partial discharge limit
- Samples tested at 4000 V_{PK} for 60 sec.; then 1358 V_{PK} for 10 sec. with 5 pC partial discharge limit

Safety-Limiting Values	Symbol	Value	Units
Safety rating ambient temperature	T_S	180	°C
Safety rating power (180°C)	P_S	270	mW
Supply current safety rating (total of supplies)	I_S	54	mA

IEC 61010-1 (Edition 2; TUV Certificate Numbers N1502812; N1502812-101)

Reinforced Insulation; Pollution Degree II; Material Group III

Part No. Suffix	Package	Working Voltage
-1	MSOP (standard)	150 V_{RMS}
V-1	MSOP (high isolation voltage)	300 V_{RMS}
-2	PDIP	300 V_{RMS}
-3	SOIC	150 V_{RMS}
None	0.3" SOIC (standard)	300 V_{RMS}
VE	0.3" SOIC (high isolation voltage)	1000 V_{RMS}

UL 1577 (Component Recognition Program File Number E207481)

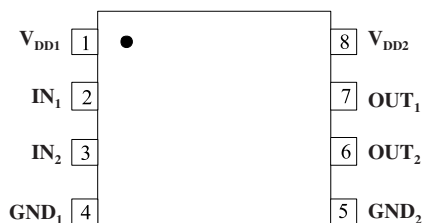
- 1 kV-rated standard MSOPs tested at 1200 V_{RMS} (1768 V_{PK}) for 1 second; each lot sample tested at 1200 V_{RMS} (1768 V_{PK}) for 1 minute
- 2.5 kV-rated parts tested at 3000 V_{RMS} (4240 V_{PK}) for 1 second; each lot sample tested at 2500 V_{RMS} (3530 V_{PK}) for 1 minute
- 6 kV-rated VE-version parts tested at 7.2 kV $_{RMS}$ (10.2 kV $_{PK}$) for 1 second; each lot sample tested at 6 kV $_{RMS}$ (8485 V_{PK}) for 1 minute

Soldering Profile

Per JEDEC J-STD-020C, MSL 1

IL711-1, -2, and -3 Pin Connections

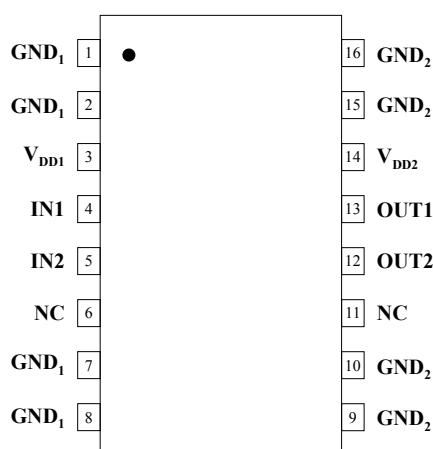
1	V _{DD1}	Supply voltage
2	IN ₁	Data in, channel 1
3	IN ₂	Data in, channel 2
4	GND ₁	Ground return for V _{DD1}
5	GND ₂	Ground return for V _{DD2}
6	OUT ₂	Data out, channel 2
7	OUT ₁	Data out, channel 1
8	V _{DD2}	Supply voltage



IL711-1, -2, and -3

IL711 Pin Connections

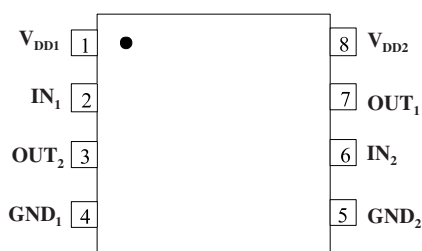
1	GND ₁	Ground return for V _{DD1}
2	GND ₁	(pins 1, 2, 7, and 8 internally connected)
3	V _{DD1}	Supply voltage
4	IN ₁	Data in, channel 1
5	IN ₂	Data in, channel 2
6	NC	No connection
7	GND ₁	Ground return for V _{DD1}
8	GND ₁	(pins 1, 2, 7, and 8 internally connected)
9	GND ₂	Ground return for V _{DD2}
10	GND ₂	(pins 9, 10, 15, and 16 internally connected)
11	NC	No connection
12	OUT ₂	Data out, channel 2
13	OUT ₁	Data out, channel 1
14	V _{DD2}	Supply voltage
15	GND ₂	Ground return for V _{DD2}
16	GND ₂	(pins 9, 10, 15, and 16 internally connected)



IL711

IL712-1, -2, and -3 Pin Connections

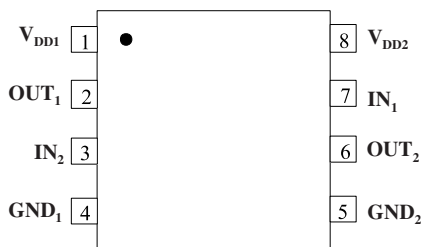
1	V _{DD1}	Supply voltage
2	IN ₁	Data in, channel 1
3	OUT ₂	Data out, channel 2
4	GND ₁	Ground return for V _{DD1}
5	GND ₂	Ground return for V _{DD2}
6	IN ₂	Data in, channel 2
7	OUT ₁	Data out, channel 1
8	V _{DD2}	Supply voltage



IL712-1, -2, and -3

IL721-3 Pin Connections

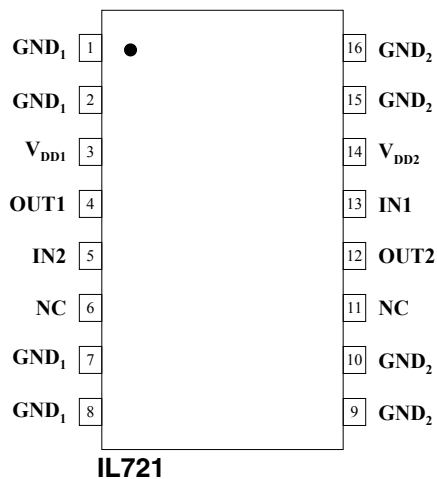
1	V _{DD1}	Supply voltage
2	OUT ₁	Data out, channel 1
3	IN ₂	Data in, channel 2
4	GND ₁	Ground return for V _{DD1}
5	GND ₂	Ground return for V _{DD2}
6	OUT ₂	Data out, channel 2
7	IN ₁	Data in, channel 1
8	V _{DD2}	Supply voltage



IL721-3

IL721 Pin Connections

1		Ground return for V_{DD1}
2	GND_1	(pins 1, 2, 7, and 8 internally connected)
3	V_{DD1}	Supply voltage
4	OUT_1	Data out, channel 1
5	IN_2	Data in, channel 2
6	NC	No connection
7	GND_1	Ground return for V_{DD1}
8		(pins 1, 2, 7, and 8 internally connected)
9	GND_2	Ground return for V_{DD2}
10		(pins 9, 10, 15, and 16 internally connected)
11	NC	No connection
12	OUT_2	Data out, channel 2
13	IN_1	Data in, channel 1
14	V_{DD2}	Supply voltage
15	GND_2	Ground return for V_{DD2}
16		(pins 9, 10, 15, and 16 internally connected)

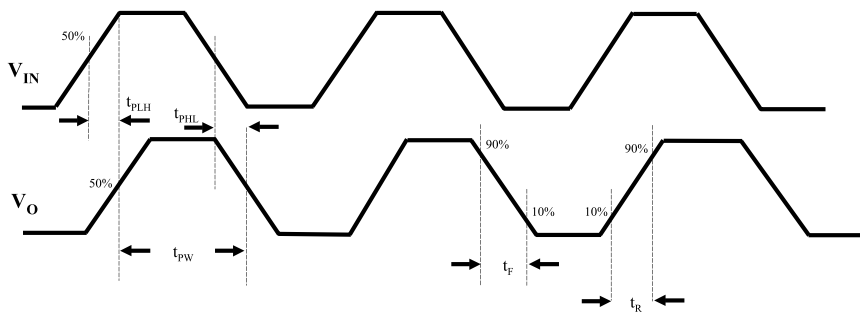


3.3 Volt Electrical Specifications (T _{min} to T _{max} unless otherwise stated)						
Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Input Quiescent Supply Current						
IL711	I _{DD1}		8	10	μA	
IL712/IL721			1.2	1.75	mA	
Output Quiescent Supply Current						
IL711	I _{DD2}		2.4	3.5	mA	
IL712/IL721			1.2	1.75	mA	
Logic Input Current	I _I	−10		10	μA	
Logic High Output Voltage	V _{OH}	V _{DD} − 0.1	V _{DD}		V	I _O = −20 μA, V _I = V _{IH}
		0.8 x V _{DD}	0.9 x V _{DD}			I _O = −4 mA, V _I = V _{IH}
Logic Low Output Voltage	V _{OL}		0	0.1	V	I _O = 20 μA, V _I = V _{IL}
			0.5	0.8		I _O = 4 mA, V _I = V _{IL}

Switching Specifications (V _{DD} = 3.3 V)						
Maximum Data Rate						
IL711/IL712/IL721		100	110		Mbps	C _L = 15 pF
IL711S/IL712S		130	140		Mbps	C _L = 15 pF
IL711T/IL712T/IL721T		100	110		Mbps	C _L = 15 pF
Pulse Width ⁽⁷⁾	PW	10	7.5		ns	50% Points, V _O
Propagation Delay Input to Output (High to Low)	t _{PHL}		12	18	ns	C _L = 15 pF
Propagation Delay Input to Output (Low to High)	t _{PLH}		12	18	ns	C _L = 15 pF
Pulse Width Distortion ⁽²⁾	PWD		2	3	ns	C _L = 15 pF
			2	3	ns	C _L = 15 pF
			1	3	ns	C _L = 15 pF
						C _L = 15 pF
Propagation Delay Skew ⁽³⁾	t _{PSK}		4	6	ns	C _L = 15 pF
Output Rise Time (10%–90%)	t _R		2	4	ns	C _L = 15 pF
Output Fall Time (10%–90%)	t _F		2	4	ns	C _L = 15 pF
Common Mode Transient Immunity (Output Logic High or Logic Low) ⁽⁴⁾	CM _H , CM _L	30	50		kV/μs	V _{CM} = 1500 V _{DC} t _{TRANSIENT} = 25 ns
Channel-to-Channel Skew	t _{CSK}		2	3	ns	C _L = 15 pF
Dynamic Power Consumption ⁽⁶⁾			140	240	μA/Mbps	per channel

Magnetic Field Immunity ⁽⁸⁾ (V _{DD2} = 3V, 3V < V _{DD1} < 5.5V)						
Power Frequency Magnetic Immunity	H _{PF}	1000	1500		A/m	50Hz/60Hz
Pulse Magnetic Field Immunity	H _{PM}	1800	2000		A/m	t _p = 8 μs
Damped Oscillatory Magnetic Field	H _{OSC}	1800	2000		A/m	0.1Hz – 1MHz
Cross-axis Immunity Multiplier ⁽⁹⁾	K _X		2.5			

Timing Diagram



Legend

t _{PLH}	Propagation Delay, Low to High
t _{PHL}	Propagation Delay, High to Low
t _{PW}	Minimum Pulse Width
t _R	Rise Time
t _F	Fall Time

5 Volt Electrical Specifications (T _{min} to T _{max} unless otherwise stated)						
Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Input Quiescent Supply Current						
IL711	I _{DD1}		10	15	μA	
IL712/IL721			1.8	2.5	mA	
Output Quiescent Supply Current						
IL711	I _{DD2}		3.6	5	mA	
IL712/IL721			1.8	2.5	mA	
Logic Input Current	I _I	-10		10	μA	
Logic High Output Voltage	V _{OH}	V _{DD} - 0.1	V _{DD}		V	I _O = -20 μA, V _I = V _{IH}
		0.8 x V _{DD}	0.9 x V _{DD}			I _O = -4 mA, V _I = V _{IH}
Logic Low Output Voltage	V _{OL}		0	0.1	V	I _O = 20 μA, V _I = V _{IL}
			0.5	0.8		I _O = 4 mA, V _I = V _{IL}

Switching Specifications (V _{DD} = 5 V)						
Maximum Data Rate						
IL711/IL712/IL721		100	110		Mbps	C _L = 15 pF
IL711S/IL712S		130	150		Mbps	C _L = 15 pF
IL711T/IL712T/IL721T		100	110		Mbps	C _L = 15 pF
Pulse Width ⁽⁷⁾	PW	10	7.5		ns	50% Points, V _O
Propagation Delay Input to Output (High to Low)	t _{PHL}		10	15	ns	C _L = 15 pF
Propagation Delay Input to Output (Low to High)	t _{PLH}		10	15	ns	C _L = 15 pF
Pulse Width Distortion ⁽²⁾	PWD		2	3	ns	C _L = 15 pF
			2	3	ns	C _L = 15 pF
			0.3	3	ns	C _L = 15 pF
Pulse Jitter ⁽¹⁰⁾	t _J		100		ps	C _L = 15 pF
Propagation Delay Skew ⁽³⁾	t _{PSK}		4	6	ns	C _L = 15 pF
Output Rise Time (10%–90%)	t _R		1	3	ns	C _L = 15 pF
Output Fall Time (10%–90%)	t _F		1	3	ns	C _L = 15 pF
Common Mode Transient Immunity (Output Logic High or Logic Low) ⁽⁴⁾	CM _H , CM _L	30	50		kV/μs	V _{CM} = 1500 V _{DC} t _{TRANSIENT} = 25 ns
Channel to Channel Skew	t _{CSK}		2	3	ns	C _L = 15 pF
Dynamic Power Consumption ⁽⁶⁾			200	340	μA/Mbps	per channel

Magnetic Field Immunity ⁽⁸⁾ (V _{DD2} = 5V, 3V < V _{DD1} < 5.5V)						
Power Frequency Magnetic Immunity	H _{PF}	2800	3500		A/m	50Hz/60Hz
Pulse Magnetic Field Immunity	H _{PM}	4000	4500		A/m	t _p = 8 μs
Damped Oscillatory Magnetic Field	H _{OSC}	4000	4500		A/m	0.1Hz – 1MHz
Cross-axis Immunity Multiplier ⁽⁹⁾	K _X		2.5			

Notes (apply to both 3.3 V and 5 V specifications):

1. Absolute maximum ambient operating temperature means the device will not be damaged if operated under these conditions. It does not guarantee performance.
2. PWD is defined as |t_{PHL} - t_{PLH}|. %PWD is equal to PWD divided by pulse width.
3. t_{PSK} is the magnitude of the worst-case difference in t_{PHL} and/or t_{PLH} between devices at 25°C.
4. CM_H is the maximum common mode voltage slew rate that can be sustained while maintaining V_O > 0.8 V_{DD2}. CM_L is the maximum common mode input voltage that can be sustained while maintaining V_O < 0.8 V. The common mode voltage slew rates apply to both rising and falling common mode voltage edges.
5. Device is considered a two terminal device: pins 1–4 shorted and pins 5–8 shorted.
6. Dynamic power consumption is calculated per channel and is supplied by the channel's input side power supply.
7. Minimum pulse width is the minimum value at which specified PWD is guaranteed.
8. The relevant test and measurement methods are given in the Electromagnetic Compatibility section on p. 6.
9. External magnetic field immunity is improved by this factor if the field direction is “end-to-end” rather than to “pin-to-pin” (see diagram on p. 6).
10. 64k-bit pseudo-random binary signal (PRBS) NRZ bit pattern with no more than five consecutive 1s or 0s; 800 ps transition time.

Application Information

Electrostatic Discharge Sensitivity

This product has been tested for electrostatic sensitivity to the limits stated in the specifications. However, NVE recommends that all integrated circuits be handled with appropriate care to avoid damage. Damage caused by inappropriate handling or storage could range from performance degradation to complete failure.

Electromagnetic Compatibility

IsoLoop Isolators have the lowest EMC footprint of any isolation technology. IsoLoop Isolators' Wheatstone bridge configuration and differential magnetic field signaling ensure excellent EMC performance against all relevant standards.

These isolators are fully compliant with generic EMC standards EN50081, EN50082-1 and the umbrella line-voltage standard for Information Technology Equipment (ITE) EN61000. NVE has completed compliance tests in the categories below:

EN50081-1

Residential, Commercial & Light Industrial
Methods EN55022, EN55014

EN50082-2: Industrial Environment

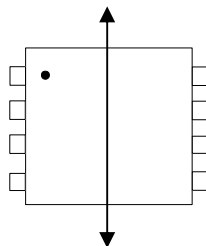
Methods EN61000-4-2 (ESD), EN61000-4-3 (Electromagnetic Field Immunity), EN61000-4-4 (Electrical Transient Immunity), EN61000-4-6 (RFI Immunity), EN61000-4-8 (Power Frequency Magnetic Field Immunity), EN61000-4-9 (Pulsed Magnetic Field), EN61000-4-10 (Damped Oscillatory Magnetic Field)

ENV50204

Radiated Field from Digital Telephones (Immunity Test)

Immunity to external magnetic fields is even higher if the field direction is "end-to-end" rather than to "pin-to-pin" as shown in the diagram below:

Cross-axis Field Direction



Dynamic Power Consumption

IsoLoop Isolators achieve their low power consumption from the way they transmit data across the isolation barrier. By detecting the edge transitions of the input logic signal and converting these to narrow current pulses, a magnetic field is created around the GMR Wheatstone bridge. Depending on the direction of the magnetic field, the bridge causes the output comparator to switch following the input logic signal. Since the current pulses are narrow, about 2.5 ns, the power consumption is independent of mark-to-space ratio and solely dependent on frequency. This has obvious advantages over optocouplers, which have power consumption heavily dependent on mark-to-space ratio.

Power Supply Decoupling

Both power supplies to these devices should be decoupled with low-ESR 47 nF ceramic capacitors. Ground planes for both GND₁ and GND₂ are highly recommended for data rates above 10 Mbps. Capacitors must be located as close as possible to the V_{DD} pins.

Maintaining Creepage

Creepage distances are often critical in isolated circuits. In addition to meeting JEDEC standards, NVE isolator packages have unique creepage specifications. Standard pad libraries often extend under the package, compromising creepage and clearance. Similarly, ground planes, if used, should be spaced to avoid compromising clearance. Package drawings and recommended pad layouts are included in this datasheet.

Signal Status on Start-up and Shut Down

To minimize power dissipation, input signals are differentiated and then latched on the output side of the isolation barrier to reconstruct the signal. This could result in an ambiguous output state depending on power up, shutdown and power loss sequencing. Unless the circuit connected to the isolator performs its own power-on reset (POR), a start-up initialization circuit should be considered. Initialization consists of toggling the input either high then low, or low then high.

In CAN applications, the IL712 or IL721 should be used with CAN transceivers with Dominant Timeout functions for seamless POR. Most CAN transceivers have Dominant Timeout options. Examples include NXP's TJA 1050 and TJA 1040 transceivers.

Data Transmission Rates

The reliability of a transmission system is directly related to the accuracy and quality of the transmitted digital information. For a digital system, those parameters which determine the limits of the data transmission are pulse width distortion and propagation delay skew.

Propagation delay is the time taken for the signal to travel through the device. This is usually different when sending a low-to-high than when sending a high-to-low signal. This difference, or error, is called pulse width distortion (PWD) and is usually in nanoseconds. It may also be expressed as a percentage:

$$\text{PWD\%} = \frac{\text{Maximum Pulse Width Distortion (ns)}}{\text{Signal Pulse Width (ns)}} \times 100\%$$

For example, with data rates of 12.5 Mbps:

$$\text{PWD\%} = \frac{3 \text{ ns}}{80 \text{ ns}} \times 100\% = 3.75\%$$

This figure is almost **three times** better than any available optocoupler with the same temperature range, and **two times** better than any optocoupler regardless of published temperature range. IsoLoop isolators exceed the 10% maximum PWD recommended by PROFIBUS, and will run to nearly 35 Mb within the 10% limit.

Propagation delay skew is the signal propagation difference between two or more channels. This becomes significant in clocked systems because it is undesirable for the clock pulse to arrive before the data has settled. Propagation delay skew is especially critical in high data rate parallel systems for establishing and maintaining accuracy and repeatability. Worst-case channel-to-channel skew in an IL700 Isolator is just 3 ns—**ten times** better than any optocoupler. IL700 Isolators have a maximum propagation delay skew of 6 ns—**five times** better than any optocoupler.

Illustrative Applications

NVE offers a unique line of single-chip isolated RS-485, PROFIBUS, and CAN transceivers, but as illustrated in the circuits below, IL700-Series Isolators can also be used as part of multi-chip designs with non-isolated transceivers:

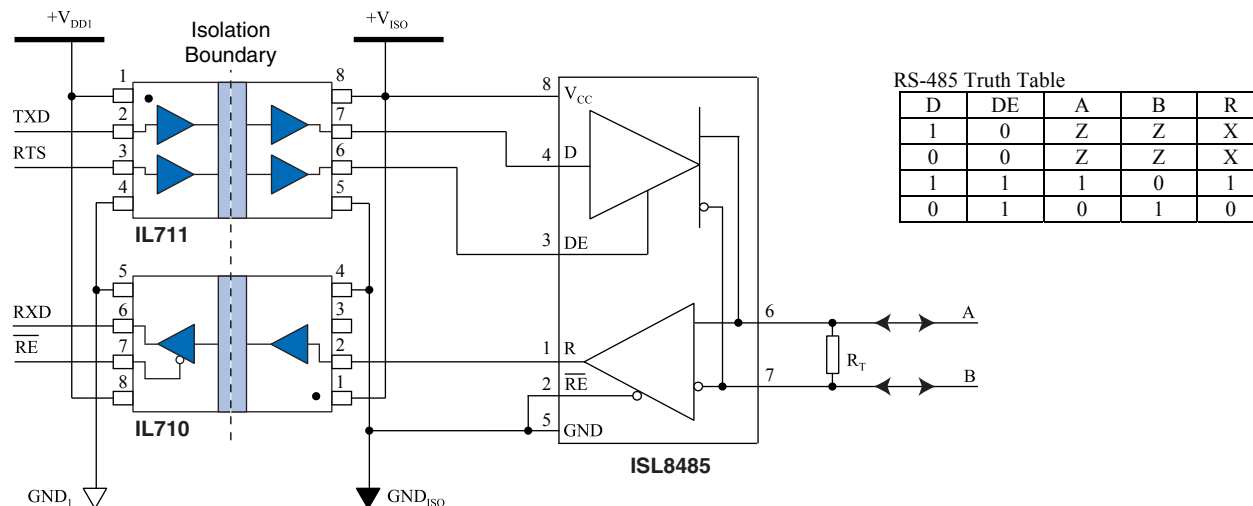


Figure 1. Isolated PROFIBUS / RS-485 circuit.

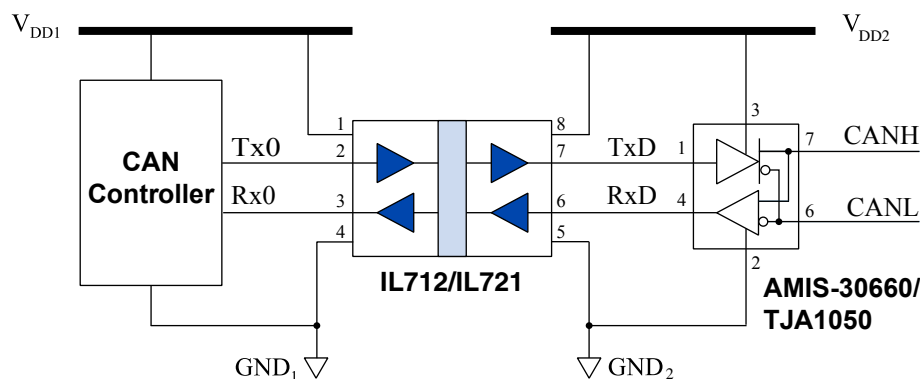


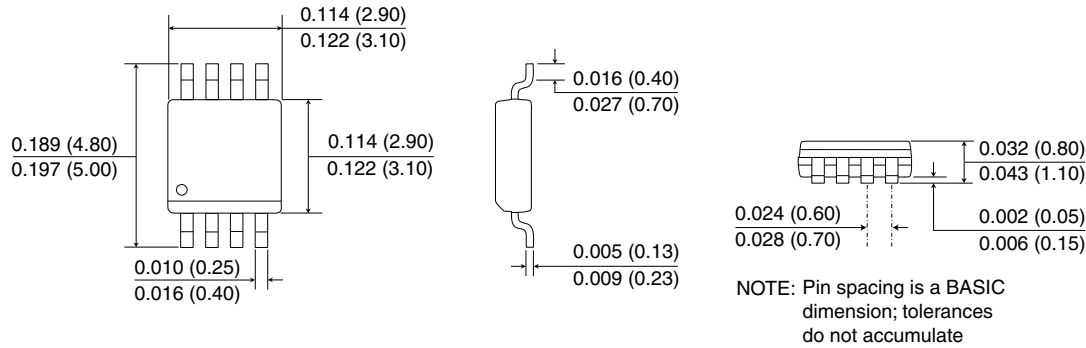
Figure 2. Isolated CAN circuit.

CAN isolation is increasingly necessary to reduce EMI susceptibility, especially in high-speed applications and in hybrid and electrical vehicle networks, where the 12 V battery has been replaced with one of several hundred volts. Operator and equipment safety becomes critical when a high voltage source, such as the battery, needs to be connected to diagnosis systems during routine maintenance procedures. In the application shown above, the microcontroller is isolated from the CAN transceiver by an IL712 or IL721, allowing higher speed and more reliable bus operation by eliminating ground loops and reducing susceptibility to noise and EMI events. The best-in-class 10 ns typical IL712/IL721 propagation delay minimizes CAN loop delay and maximizes data rate over any given bus length. This simple circuit works with any CAN transceiver with a TxD dominant timeout, which includes all of the current-generation transceivers.

Package Drawings

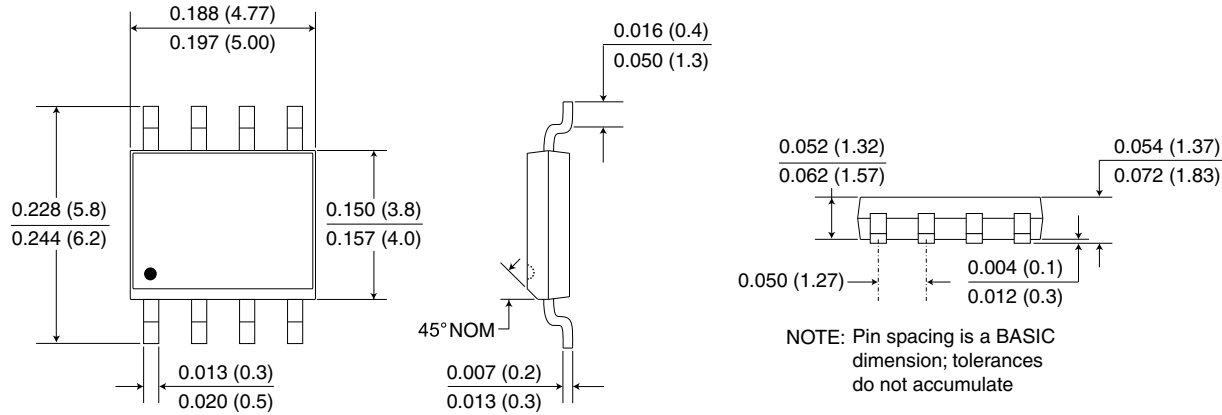
8-pin MSOP (-1 suffix)

Dimensions in inches (mm); scale = approx. 5X



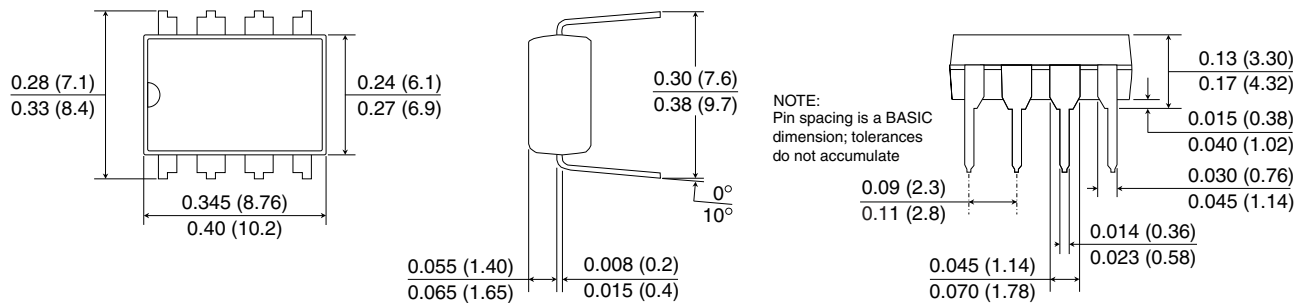
8-pin SOIC Package (-3 suffix)

Dimensions in inches (mm); scale = approx. 5X



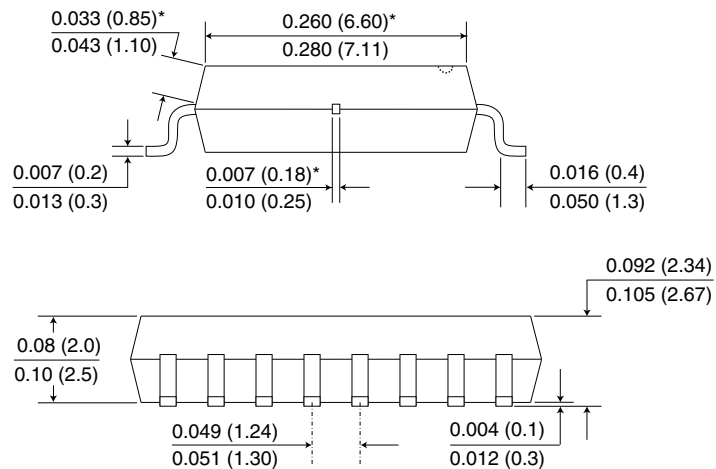
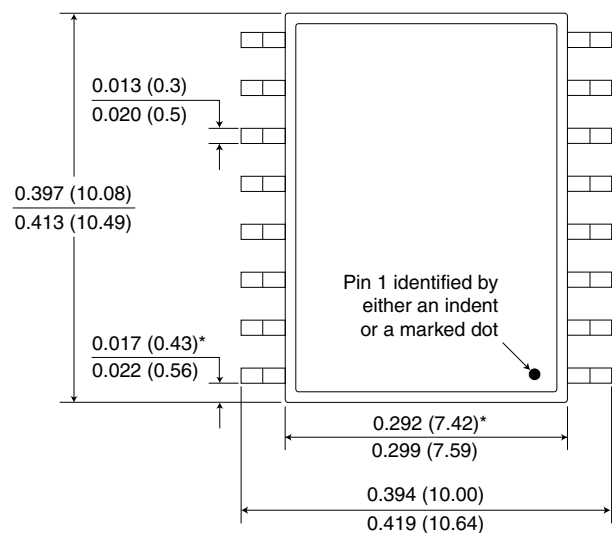
8-pin PDIP (-2 suffix)

Dimensions in inches (mm); scale = approx. 2.5X



True 8™ (8 mm creepage) 16-pin SOIC Package (no suffix)

Dimensions in inches (mm); scale = approx. 5X



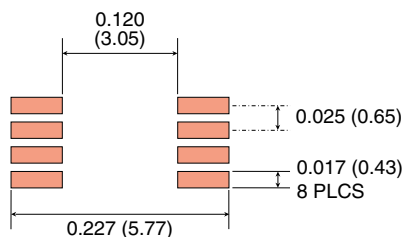
NOTE: Pin spacing is a BASIC dimension; tolerances do not accumulate

*Specified for True 8™ package to guarantee 8 mm creepage per IEC 60601.

Recommended Pad Layouts

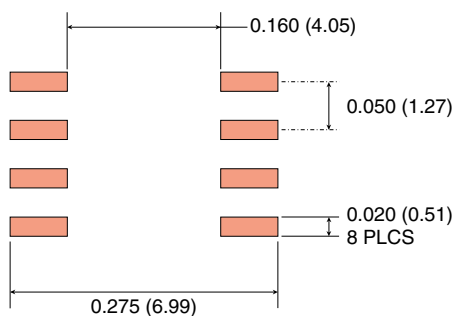
8-pin MSOP Pad Layout

Dimensions in inches (mm); scale = approx. 5X



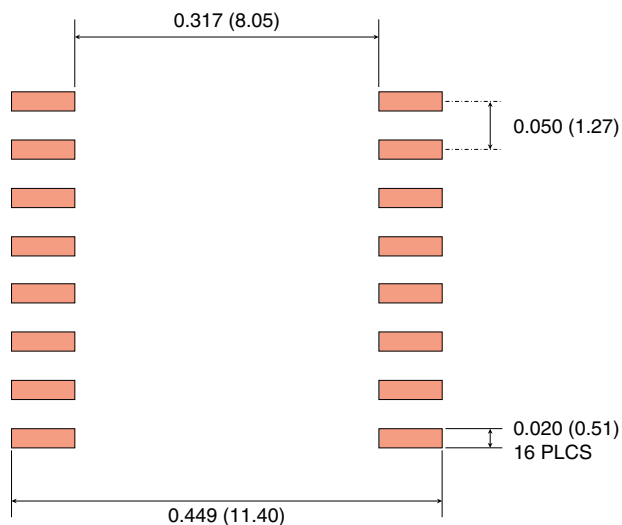
8-pin SOIC Pad Layout

Dimensions in inches (mm); scale = approx. 5X



True 8™ 16-pin SOIC Pad Layout

Dimensions in inches (mm); scale = approx. 5X



Ordering Information

IL 711 T - 3 E TR13

→ **Bulk Packaging**

Blank = Tube
TR7 = 7" Tape and Reel
TR13 = 13" Tape and Reel

→ **Package**

Blank = 80/20 Tin/Lead Plating
E = RoHS Compliant

→ **Package Type**

-1 = MSOP
-2 = PDIP
-3 = 0.15" 8-pin SOIC
Blank = True 8 (8mm creepage)

→ **Grade**

Blank = Standard
S = High Speed (150 Mbps)
T = High Temperature (125°C)
V = High Isolation Voltage
(6 kV True 8; 2.5 kV MSOP)

→ **Base Part Number**

711 = 2 Transmit Channels
712 = 1 Transmit Channel
1 Receive Channel
721 = 1 Transmit Channel
1 Receive Channel
(reverse pinout)

→ **Product Family**

IL = Isolators

Valid Part Numbers

IL711E	IL712-1E	IL721E
IL711TE	IL712S-1E	IL721TE
IL711VE	IL712T-1E	IL721VE
	IL712TV-1E	
IL711-1E	IL712V-1E	IL721-3
IL711S-1E		IL721-3E
IL711T-1E	IL712-2	IL721T-3
IL711TV-1E	IL712-2E	IL721T-3E
IL711V-1E	IL712T-2	
	IL712T-2E	
IL711-2		
IL711-2E	IL712-3	
IL711T-2	IL712S-3	
IL711T-2E	IL712T-3	
	IL712-3E	
IL711-3	IL712S-3E	
IL711S-3	IL712T-3E	
IL711T-3		
IL711-3E		
IL711S-3E		
IL711T-3E		

All MSOP and SOIC parts are available on tape and reel.

Available Parts

Available Parts	Transmit Channels	Receive Channels	Mbps	Maximum Temperature	Isolation Voltage (RMS)	Package	RoHS
IL711-1E	2	0	110	100°C	1 kV	MSOP-8	Y
IL711-2	2	0	110	100°C	2.5 kV	PDIP-8	N
IL711-2E	2	0	110	100°C	2.5 kV	PDIP-8	Y
IL711-3	2	0	110	100°C	2.5 kV	SOIC-8	N
IL711-3E	2	0	110	100°C	2.5 kV	SOIC-8	Y
IL711S-1E	2	0	150	100°C	1 kV	MSOP-8	Y
IL711S-3E	2	0	150	100°C	2.5 kV	SOIC-8	Y
IL711T-1E	2	0	110	125°C	1 kV	MSOP-8	Y
IL711TV-1E	2	0	110	125°C	2.5 kV	MSOP-8	Y
IL711T-2	2	0	110	125°C	2.5 kV	PDIP-8	N
IL711T-2E	2	0	110	125°C	2.5 kV	PDIP-8	Y
IL711T-3	2	0	110	125°C	2.5 kV	SOIC-8	N
IL711T-3E	2	0	110	125°C	2.5 kV	SOIC-8	Y
IL711V-1E	2	0	110	100°C	2.5 kV	MSOP-8	Y
IL711VE	2	0	110	125°C	6 kV	True8	Y
IL712-1E	1	1	110	100°C	1 kV	MSOP-8	Y
IL712-2	1	1	110	100°C	2.5 kV	PDIP-8	N
IL712-2E	1	1	110	100°C	2.5 kV	PDIP-8	Y
IL712-3	1	1	110	100°C	2.5 kV	SOIC-8	N
IL712-3E	1	1	110	100°C	2.5 kV	SOIC-8	Y
IL712S-1E	1	1	150	100°C	1 kV	MSOP-8	Y
IL712S-3E	1	1	150	100°C	2.5 kV	SOIC-8	Y
IL712T-1E	1	1	110	125°C	1 kV	MSOP-8	Y
IL712TV-1E	1	1	110	125°C	2.5 kV	MSOP-8	Y
IL712T-2	1	1	110	125°C	2.5 kV	PDIP	N
IL712T-2E	1	1	110	125°C	2.5 kV	PDIP	Y
IL712T-3	1	1	110	125°C	2.5 kV	SOIC-8	N
IL712T-3E	1	1	110	125°C	2.5 kV	SOIC-8	Y
IL712V-1E	1	1	110	100°C	2.5 kV	MSOP	Y
IL721-3E	1	1	110	105°C	2.5 kV	SOIC-8	Y
IL721E	1	1	110	100°C	2.5 kV	True8	Y
IL721T-3E	1	1	110	125°C	2.5 kV	SOIC-8	Y
IL721VE	1	1	110	125°C	6 kV	True8	Y

All MSOP and SOIC part types are available on tape and reel.

ISB-DS-001-IL711/12-AL
June 2018

Change

- Added IL711TV-1E and IL712TV-1E 125°C, 2.5 kV isolation MSOP configurations.
- Eliminated non-RoHS MSOPs.

ISB-DS-001-IL711/12-AK

Change

- Updated SOIC8 package outline drawing.

ISB-DS-001-IL711/12-AJ

Change

- Updated VDE Reinforced Isolation file number and description.

ISB-DS-001-IL711/12-AI

Changes

- Updated VDE certification standard to VDE V 0884-10.
- Upgraded “VE” Version Surge Immunity specification to 12.8 kV.
- Upgraded “VE” Version VDE 0884-10 rating to reinforced insulation.

ISB-DS-001-IL711/12-AH

Changes

- Increased V-Series isolation voltage to 6 kVrms.
- Increased typ. Total Barrier Thickness specification to 0.016 mm.
- Increased CTI min. specification to $\geq 600 V_{RMS}$.

ISB-DS-001-IL711/12-AG

Changes

- Added V-Series high isolation voltage versions (5 kV True 8 and 2.5 kV MSOP).
- More detailed “Available Parts” table.

ISB-DS-001-IL711/12-AF

Changes

- Added product illustrations to first page.
- Revised and added details to thermal characteristic specifications (p. 2).
- Added VDE 0884 Safety-Limiting Values (p. 3).

ISB-DS-001-IL711/12-AE

Changes

- IEC 60747-5-5 (VDE 0884) certification.

ISB-DS-001-IL711/12-AD

Changes

- Tighter quiescent current specifications.
- Upgraded from MSL 2 to MSL 1.

ISB-DS-001-IL711/12-AC

Changes

- Increased transient immunity specifications based on additional data.
- Added VDE 0884 information.
- Added high voltage endurance specification.
- Increased magnetic immunity specifications.
- Updated package drawings.
- Added recommended solder pad layouts.

ISB-DS-001-IL711/12-AB

Changes

- Added wide-body package option.
- VDE0884 compliance pending.
- Added recommended solder pad layouts.

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ISB-DS-001-IL711/12-AL

June 2018